

**Search Notes**

Application/Control No.

10/710,765

Examiner

Thien F. Tran

Applicant(s)/Patent under  
Reexamination

WU ET AL.

Art Unit

2811

**SEARCHED**

Class	Subclass	Date	Examiner
257	324-325	1/19/2005	TT
438	216, 261	1/19/2005	TT
438	591, 593	1/19/2005	TT
257	316-317	1/19/2005	TT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
257	324, 325	1/19/2005	TT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR